

BUL38D

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- STMicroelectronics PREFERRED SALESTYPE
- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- LOW BASE-DRIVE REQUIREMENTS
- VERY HIGH SWITCHING SPEED
- FULLY CHARACTERISED AT 125°C
- HIGH RUGGEDNESS
- INTEGRATED ANTIPARALLEL COLLECTOR-EMITTER DIODE

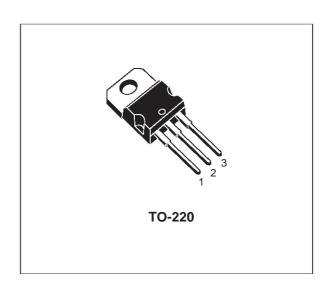
APPLICATIONS

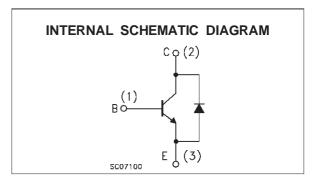
- ELECTRONIC TRANSFORMERS FOR HALOGEN LAMPS
- SWITCH MODE POWER SUPPLIES



The BUL38D is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and high voltage withstand capability.

The BUL series is designed for use in lighting applications and low cost switch-mode power supplies.





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
Vces	Collector-Emitter Voltage (V _{BE} = 0)	800	V
V_{CEO}	Collector-Emitter Voltage (I _B = 0)	450	V
V _{EBO}	Emitter-Base Voltage (I _C = 0)	9	V
Ic	Collector Current	5	V
I _{CM}	Collector Peak Current (t _p <5 ms)	10	A
Ι _Β	Base Current	2	A
I _{BM}	Base Peak Current (t _p <5 ms)	4	A
P _{tot}	Total Dissipation at Tc = 25 °C	80	W
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

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THERMAL DATA

R _{thj-case}	Thermal Resistance Junction-Case	Max	1.56	°C/W
R _{thj-amb}	Thermal Resistance Junction-Ambient	Max	62.5	°C/W

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

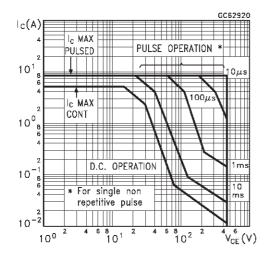
Symbol	Parameter	Test Conditions			Тур.	Max.	Unit
I _{CES}	Collector Cut-off Current (V _{BE} = 0)	V _{CE} = 800 V V _{CE} = 800 V	T _j = 125 °C			100 500	μA μA
I _{CEO}	Collector Cut-off Current (I _B = 0)	V _{CE} = 450 V				250	μΑ
V _{CEO(sus)*}	Collector-Emitter Sustaining Voltage (I _B = 0)	I _C = 100 mA	L = 25 mH	450			V
V _{EBO}	Emitter-Base Voltage (I _C = 0)	I _E = 10 mA		9			V
V _{CE(sat)} *	Collector-Emitter Saturation Voltage	I _C = 1 A I _C = 2 A I _C = 3 A	$I_B = 0.2 A$ $I_B = 0.4 A$ $I_B = 0.75 A$			0.5 0.7 1.1	V V V
V _{BE(sat)} *	Base-Emitter Saturation Voltage	I _C = 1 A I _C = 2 A	I _B = 0.2 A I _B = 0.4 A			1.1 1.2	V V
h _{FE} *	DC Current Gain	I _C = 10 mA I _C = 0.5 A I _C = 2 A Group A	$V_{CE} = 5 V$ $V_{CE} = 5 V$ $V_{CE} = 5 V$	10		60	
t _s	RESISTIVE LOAD Storage Time Fall Time	Group B $I_C = 2.5 \text{ A}$ $I_{B1} = -I_{B2} = 0.5 \text{ A}$	$V_{CC} = 150 \text{ V}$ $t_p = 30 \mu\text{s}$	1.0		2.2 0.8	μs μs
t _s	INDUCTIVE LOAD Storage Time Fall Time	I _C = 2 A V _{BE(off)} = -5 V V _{CL} = 250 V	$I_{B1} = 0.4 \text{ A}$ $R_{BB} = 0 \Omega$ $L = 200 \mu H$		1 55	1.8 100	μs ns
t _s	INDUCTIVE LOAD Storage Time Fall Time	$I_{C} = 2 \text{ A}$ $V_{BE(off)} = -5 \text{ V}$ $V_{CL} = 250 \text{ V}$ $T_{j} = 125 \text{ °C}$	$I_{B1} = 0.4 \text{ A}$ $R_{BB} = 0 \Omega$ $L = 200 \mu\text{H}$		1.3 100		μs ns
V _f	Diode Forward Voltage	I _C = 2 A				1.5	V

* Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.

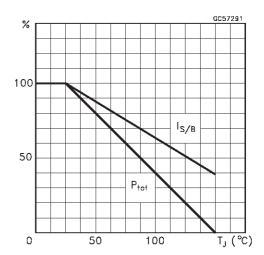
The product is pre-selected in DC current gain (Group A and Group B). STMicroelectronics reserves the right to ship either groups according to production availability. Please contact your nearest STMicroelectronics sales office for delivery datails.

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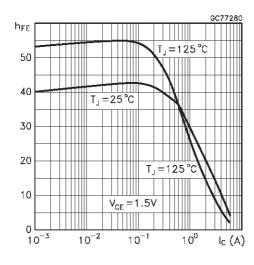
Safe Operating Area



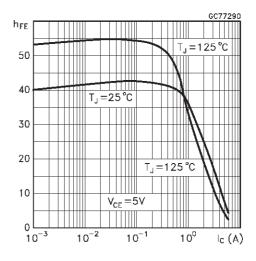
Derating Curve



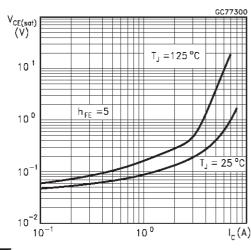
DC Current Gain



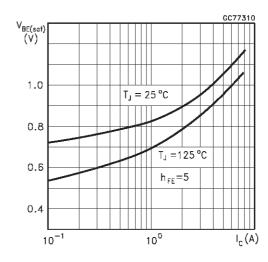
DC Current Gain



Collector-Emitter Saturation Voltage

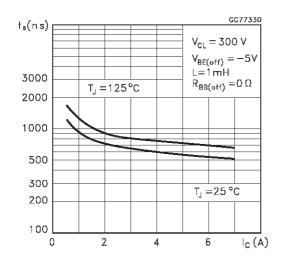


Base-Emitter Saturation Voltage

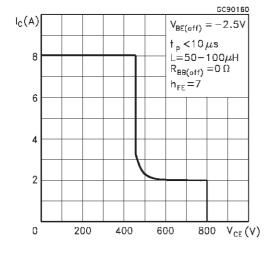


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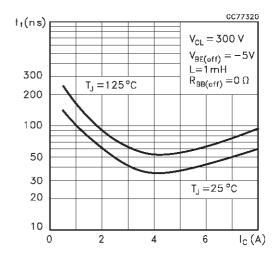
Inductive Storage Time



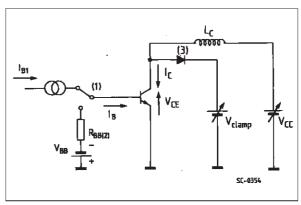
Reverse Biased SOA



Inductive Fall Time



RBSOA and Inductive Load Switching Test Circuit

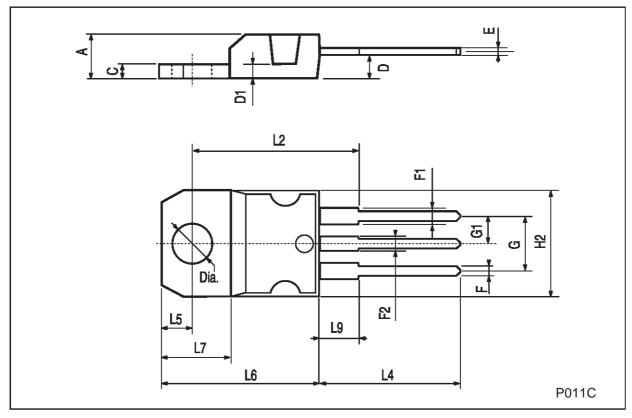


- (1) Fast electronic switch(2) Non-inductive Resistor(3) Fast recovery rectifier

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TO-220 MECHANICAL DATA

DIM.	mm			inch			
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	4.40		4.60	0.173		0.181	
С	1.23		1.32	0.048		0.051	
D	2.40		2.72	0.094		0.107	
D1		1.27			0.050		
Е	0.49		0.70	0.019		0.027	
F	0.61		0.88	0.024		0.034	
F1	1.14		1.70	0.044		0.067	
F2	1.14		1.70	0.044		0.067	
G	4.95		5.15	0.194		0.203	
G1	2.4		2.7	0.094		0.106	
H2	10.0		10.40	0.393		0.409	
L2		16.4			0.645		
L4	13.0		14.0	0.511		0.551	
L5	2.65		2.95	0.104		0.116	
L6	15.25		15.75	0.600		0.620	
L7	6.2		6.6	0.244	_	0.260	
L9	3.5		3.93	0.137		0.154	
DIA.	3.75		3.85	0.147		0.151	



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